

**Search Notes**

Application/Control No.

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Examiner

Martin Lerner

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

2626

**SEARCHED**

Class	Subclass	Date	Examiner
704	200, 200.1, 219, 500, 501, 503	11/26/2007	ML

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search Attached	11/26/2007	ML